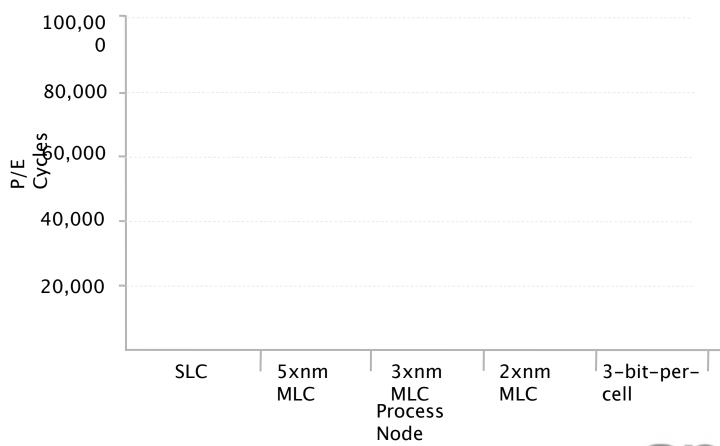


A New Era in Embedded Flash Memory

by
Ariel Maislos, President
Anobit Technologies



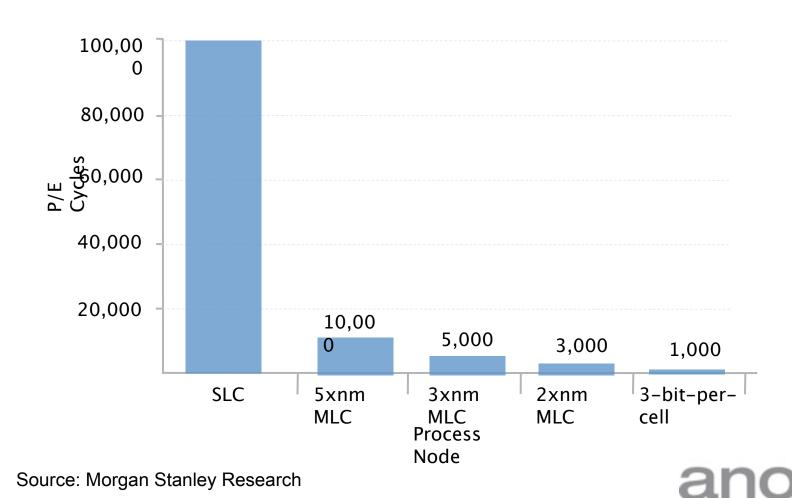




Source: Morgan Stanley Research

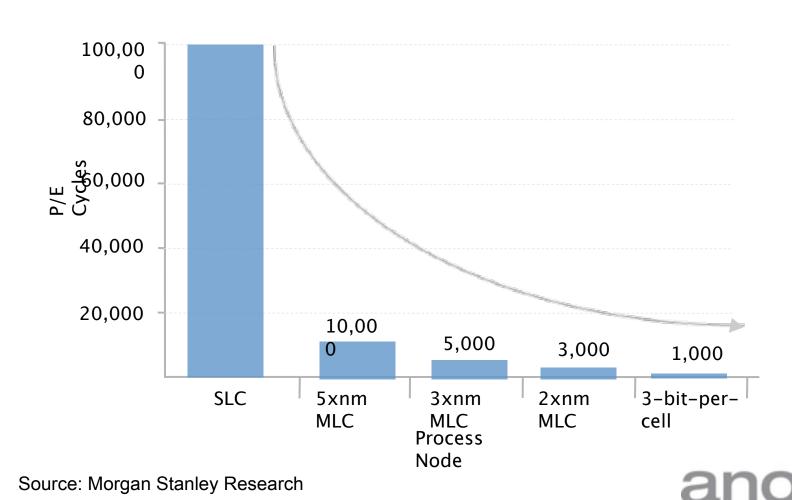






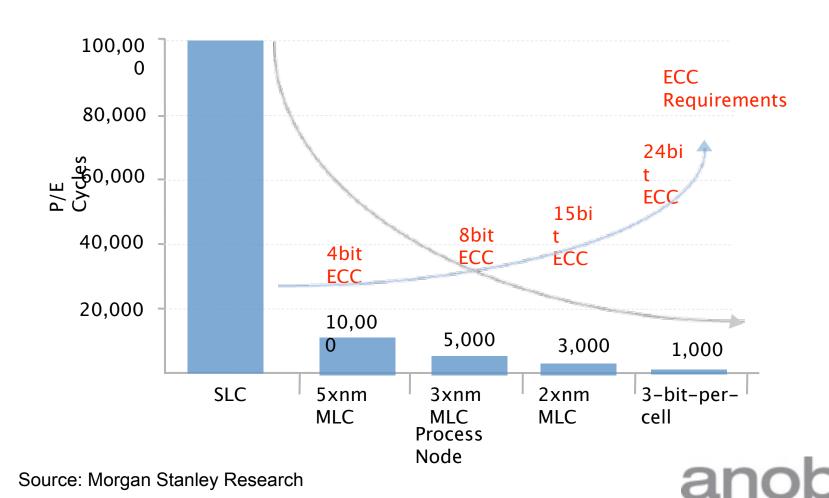
add another bit





add another bit

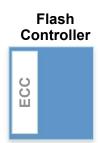




add another bit



Flash Memory Flash Controller Evolution







Flash Memory Flash Controller Evolution

Flash Controller





Flash Controller







Flash Controller Evolution

Flash Controller



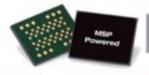


Flash Controller



MSP[™] – Memory Signal Processing

77 patent applications (19 granted)



Boosting Endurance by X20

Error Reduction

Compensates for process and array impairments
 Cross coupling, Read disturbs, Program disturbs, Data retention impairments, Endurance impairments

Error Correction

Advanced ECC with improved error correction capabilities

Anobit Proprietary & Confidential

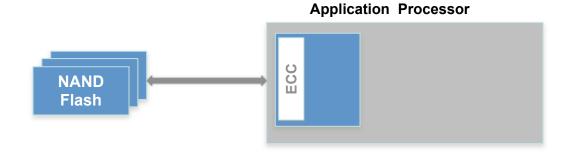








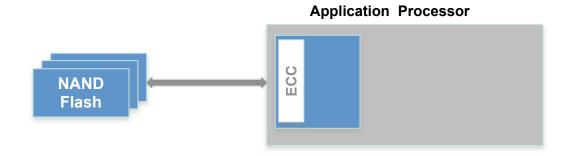
Flash Memory Architectural Changes

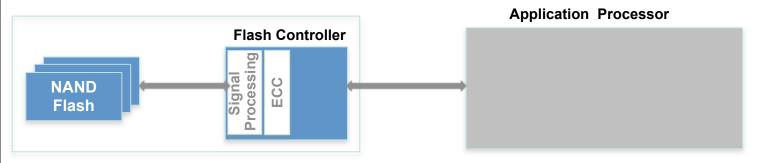






Flash Memory Architectural Changes

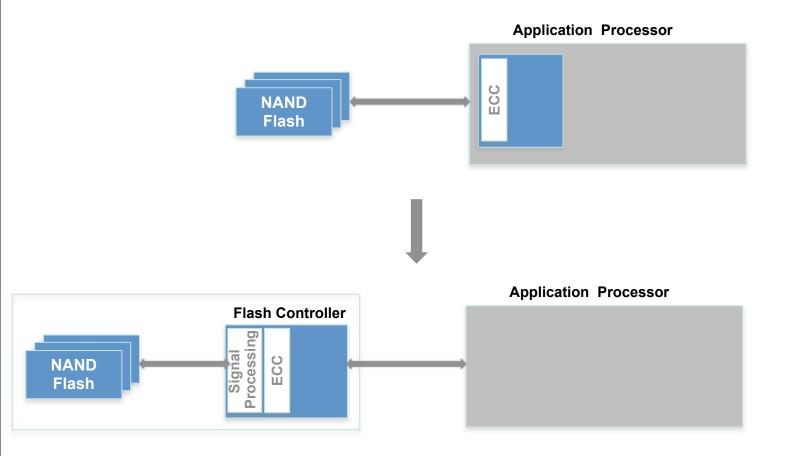








Flash Memory Architectural Changes

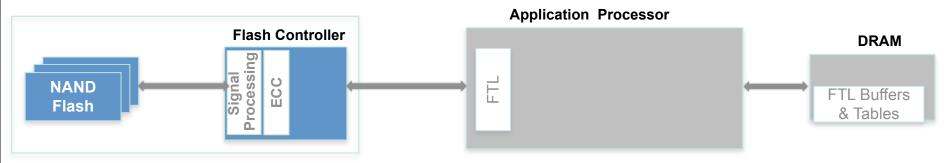




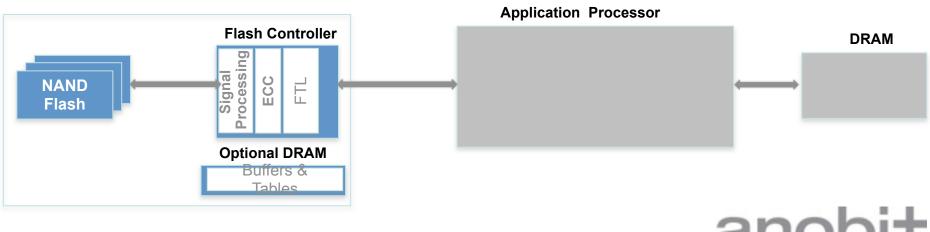


Flash Memory Architectural Changes (cont.)

Half-Managed NAND



Managed NAND





Flash Memory Architectural Changes (cont.)

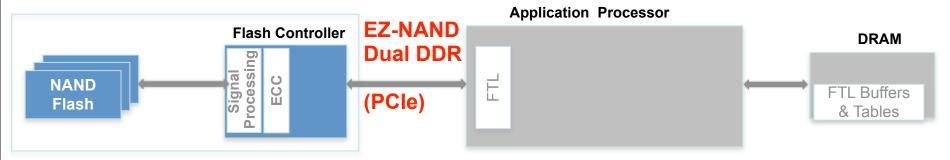
	Abstraction	Performance	Host DRAM	Power Efficiency (MIPS/Watt)
Unmanaged	Low	High	Yes	High
Half-Managed	Medium	High	Yes	High
Managed	High	Low	No	Medium



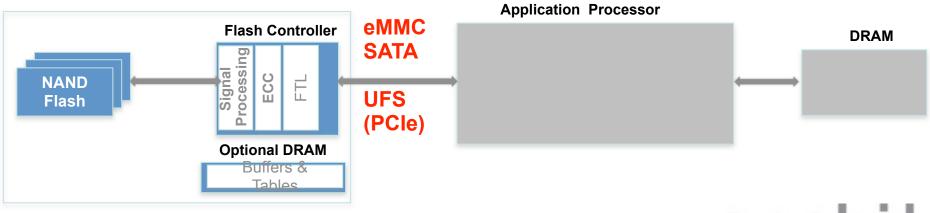


Interface Alternatives

Half-Managed NAND



Managed NAND







Flash Memory Comparison Table

		EZ- NAND	Dual DDR	eMMC4.5	SATA2	UFS	PCIe
Α	rchitectur e	Half – Manage d	Half – Managed	Managed	Managed	Managed	TBD
Т	hroughpu t	200 to 400MB ps	666MBps	200MBps	375MBps	375MBps Per lane	625MBps Per lane
	I/F Power Consumpti on Pineline	Mediu m	Medium	Medium	High	Low	High
Pipe	Pipeline	No	Yes	Yes	Yes	Yes	Yes
	Out Of Order	No	No	No	Partial (between tags)	Full	Full
	RAM	Host	Host	Local	Local	Local ϵ	anob
	Availahility	Shippin	Shinnina	Shinnina	Shinnina	Future	add and Future

Thursday, August 25, 11



- NAND scale-down results a severe degradation in cell endurance
- Advanced flash controller technologies are required
- A new era in embedded flash is emerging, based on managed and half-managed NAND architectures
- Current and future standards offer a tool-box for optimizing system performance





Thank You!

